

A few words on source setup simulation + charge spread

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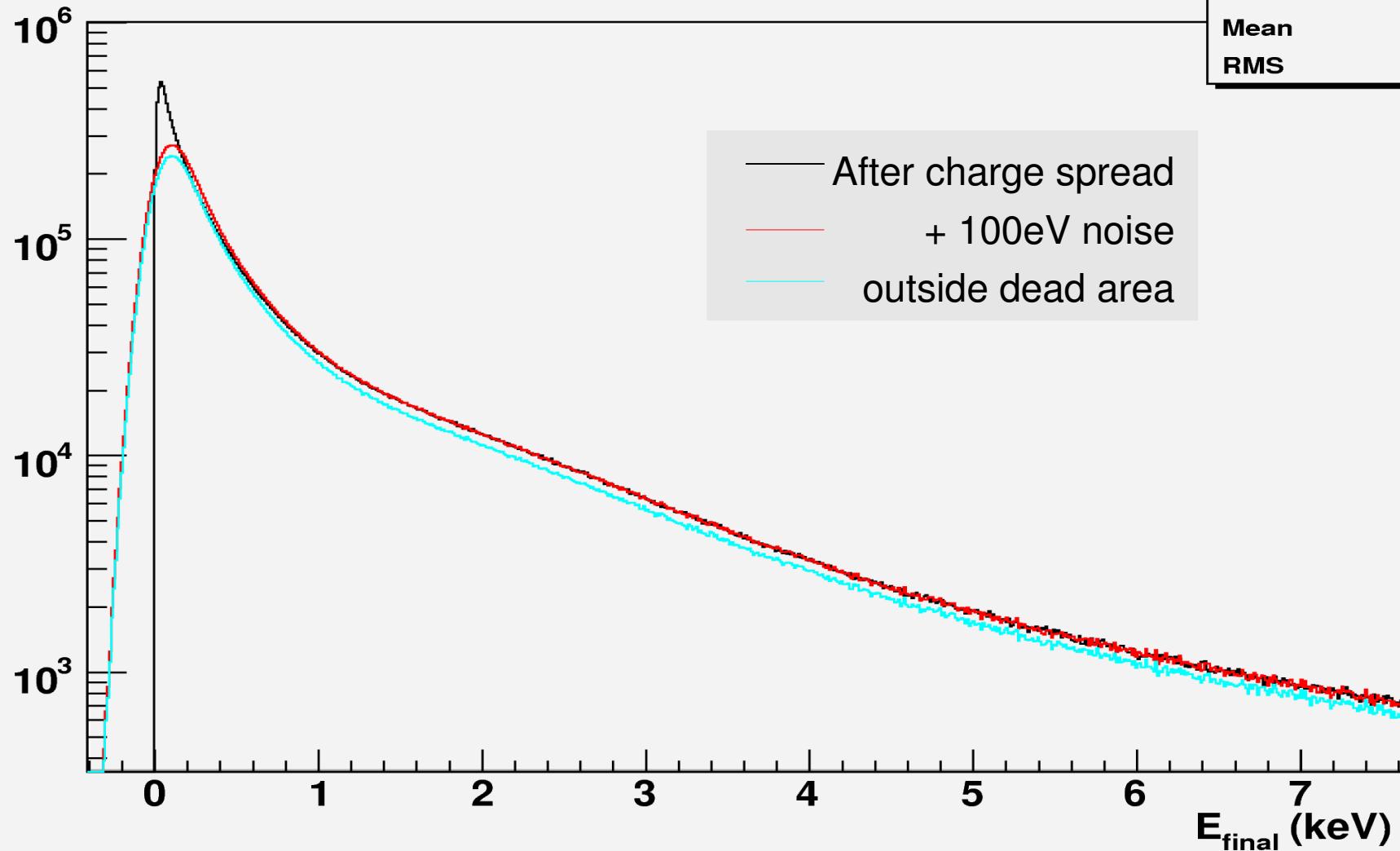
Introduction

- Very simple implementation within Mokka
- “Hacking” the CGAGeometryManager to accept hardcoded geometry (and not through the database....)
- Adapted digiMAPS => digiTB, but LCIO is not appropriate like it is now to create easily BunchTrains.
- TB setup is also roughly there....
- Idea started to add properly noise only hits/BX: create a RootTree with BunchTrains containing BX containing hits (+MC hits when applicable) => would be the basis of an analysis framework also for real data.

Thallium, $E_{\text{end}} = 766 \text{ keV}$

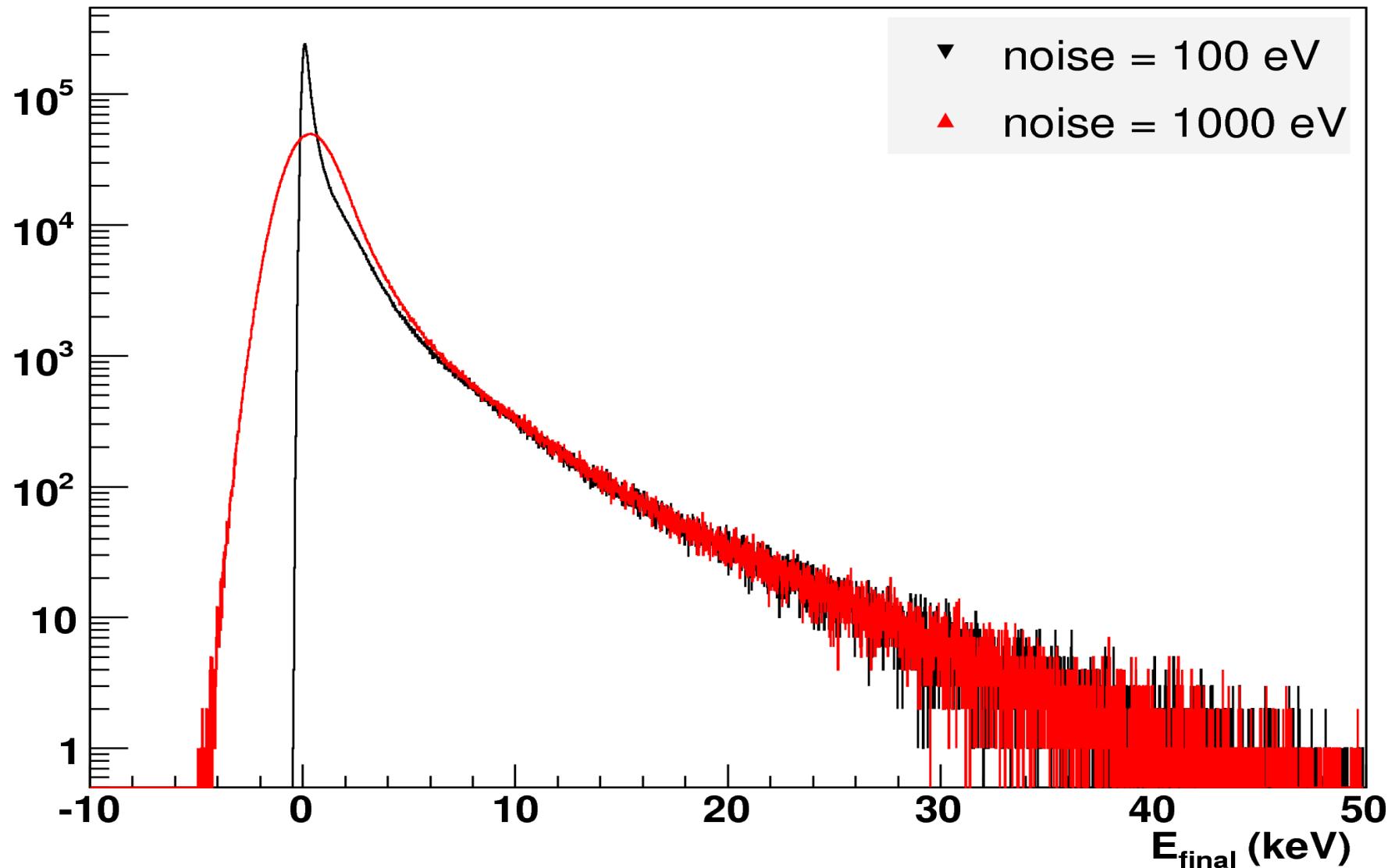
Energy after charge spread of all Sim hits in ECAL

p_Efinal	
Entries	1.447474e+07
Mean	0.7611
RMS	1.17



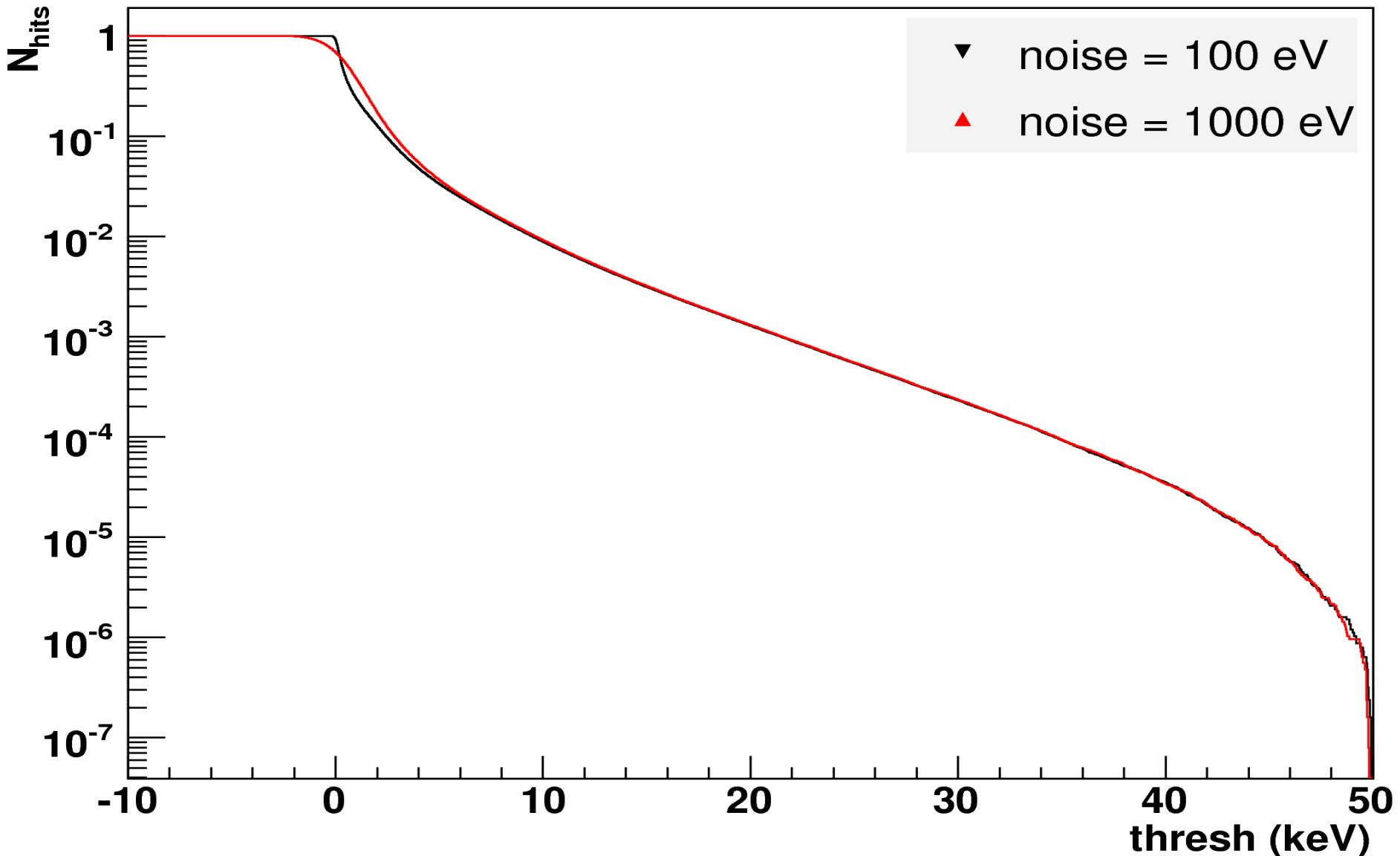
Thallium, $E_{\text{end}} = 766 \text{ keV}$

Energy after charge spread+noise of alive hits in ECAL



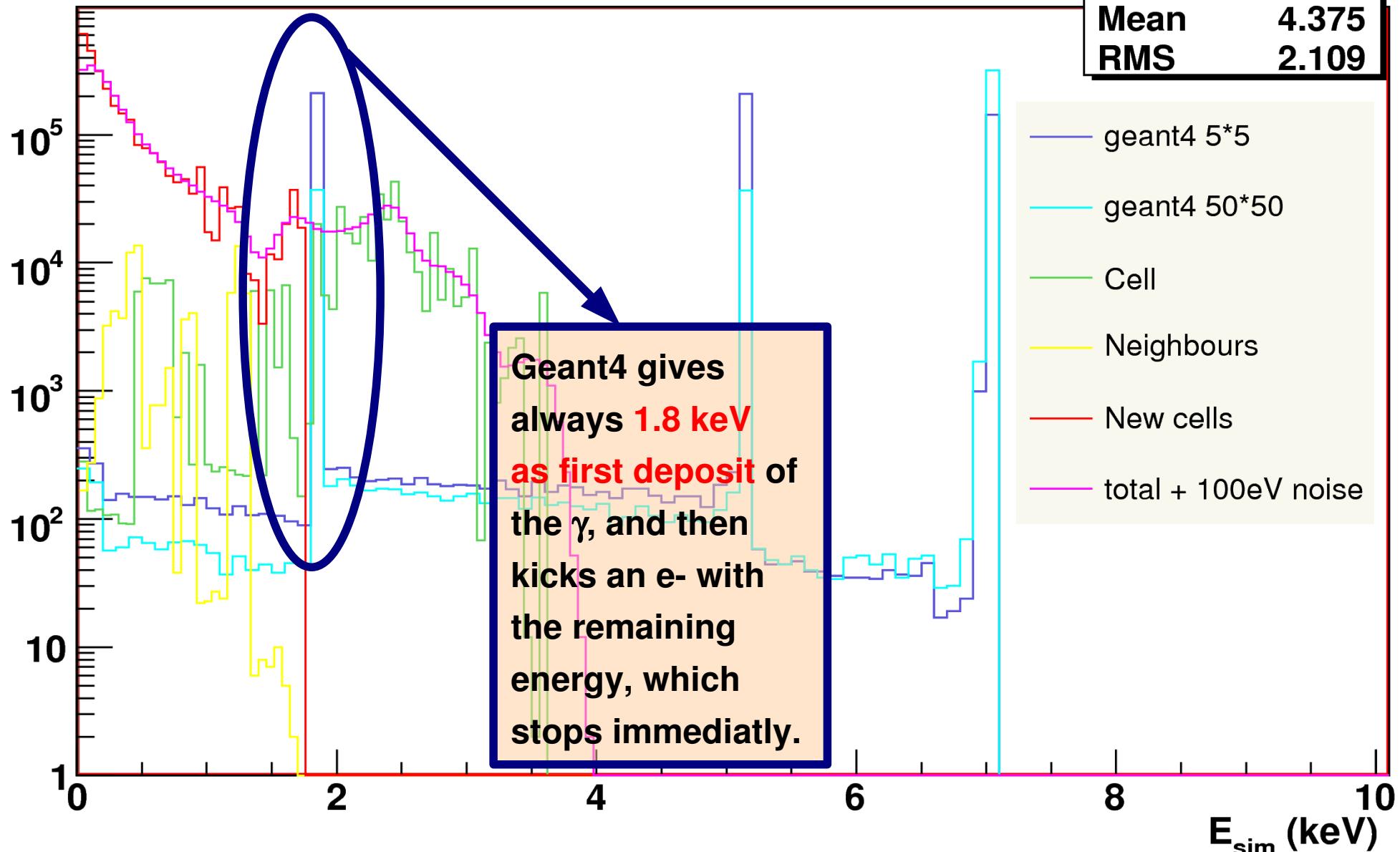
Thallium, $E_{\text{end}} = 766 \text{ keV}$

N_{hits} vs threshold



^{55}Fe , $\gamma = 7 \text{ keV}$

Geant4 energy of generated hits in ECAL

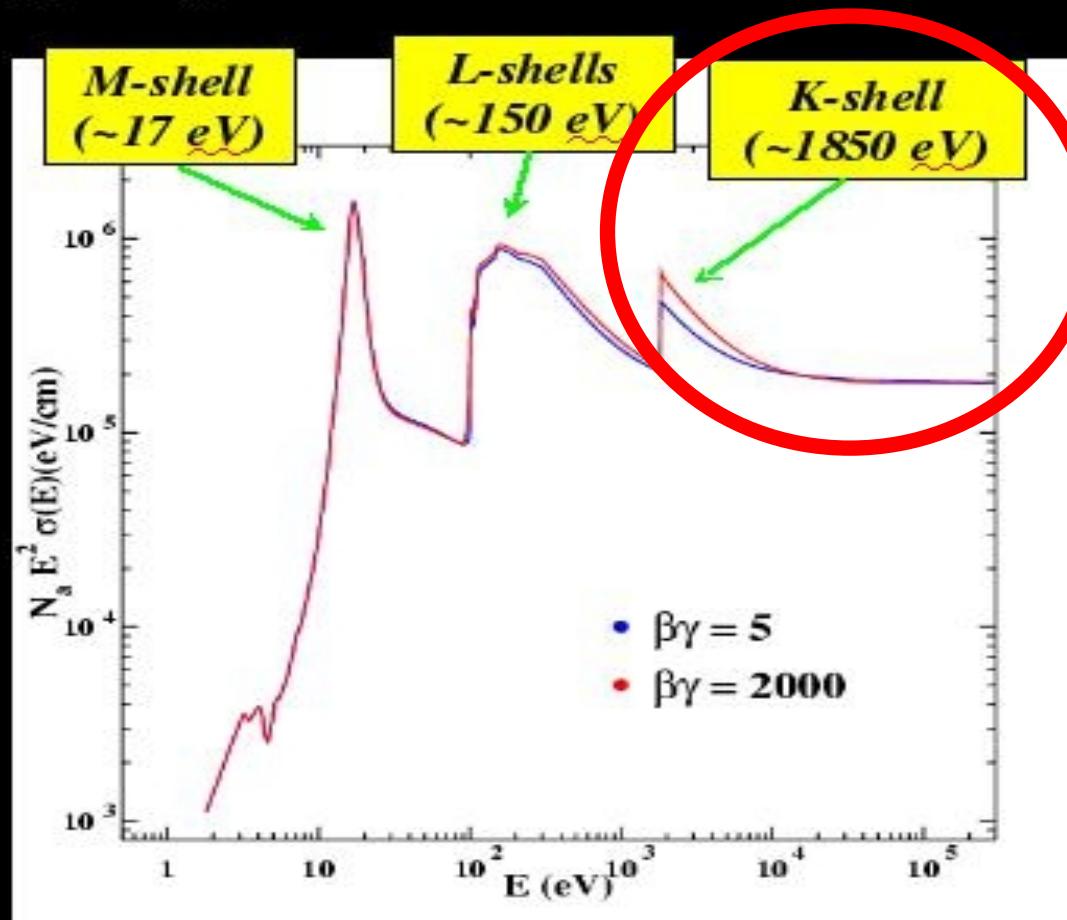


Energy loss of charged particles in silicon

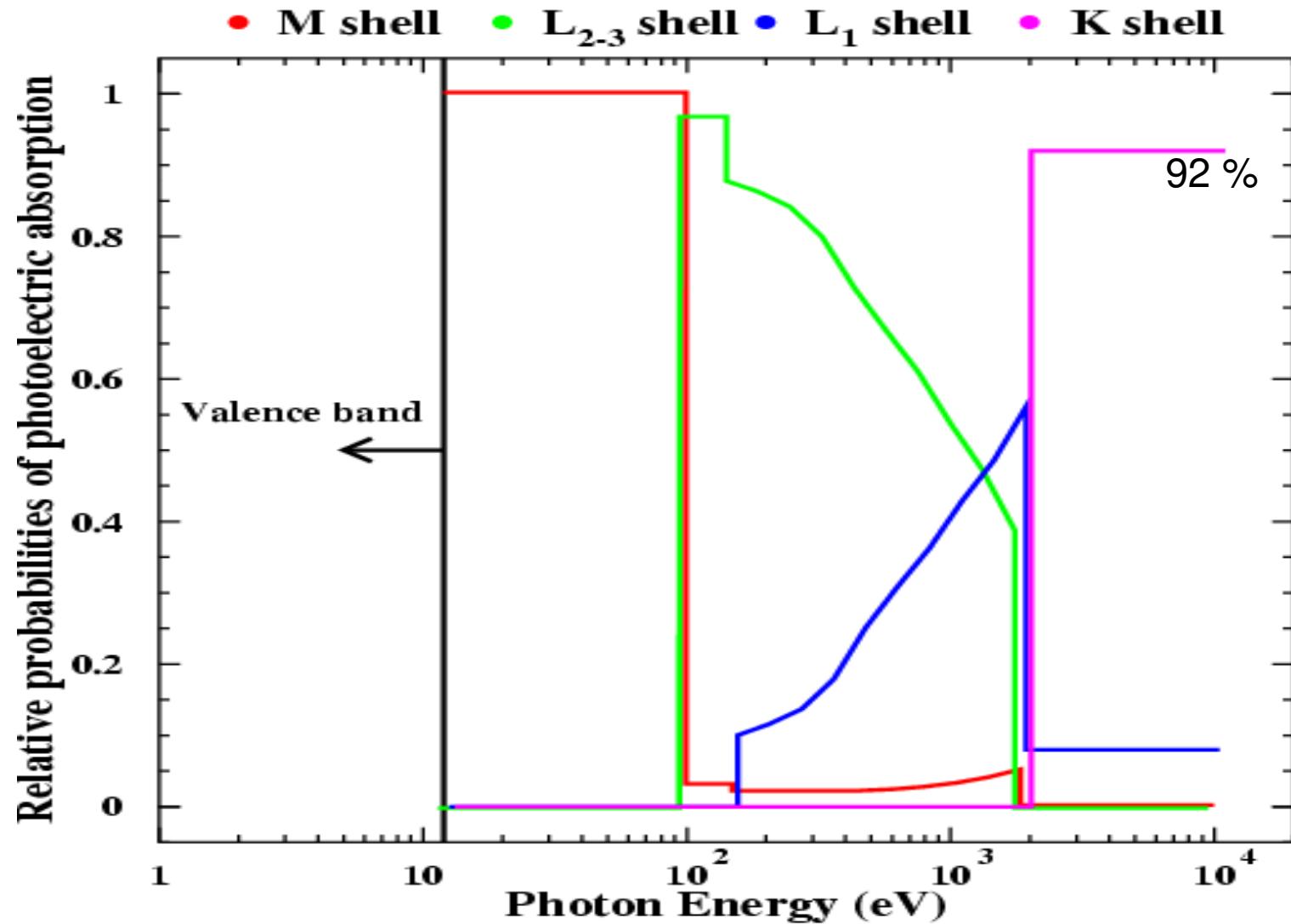
The energy loss in Si is evaluated from the collision cross section $\sigma(E)$ (H. Bichsel, Rev. Mod. Phys. 60, 663)



The number of collisions per unit path length is evaluated as:



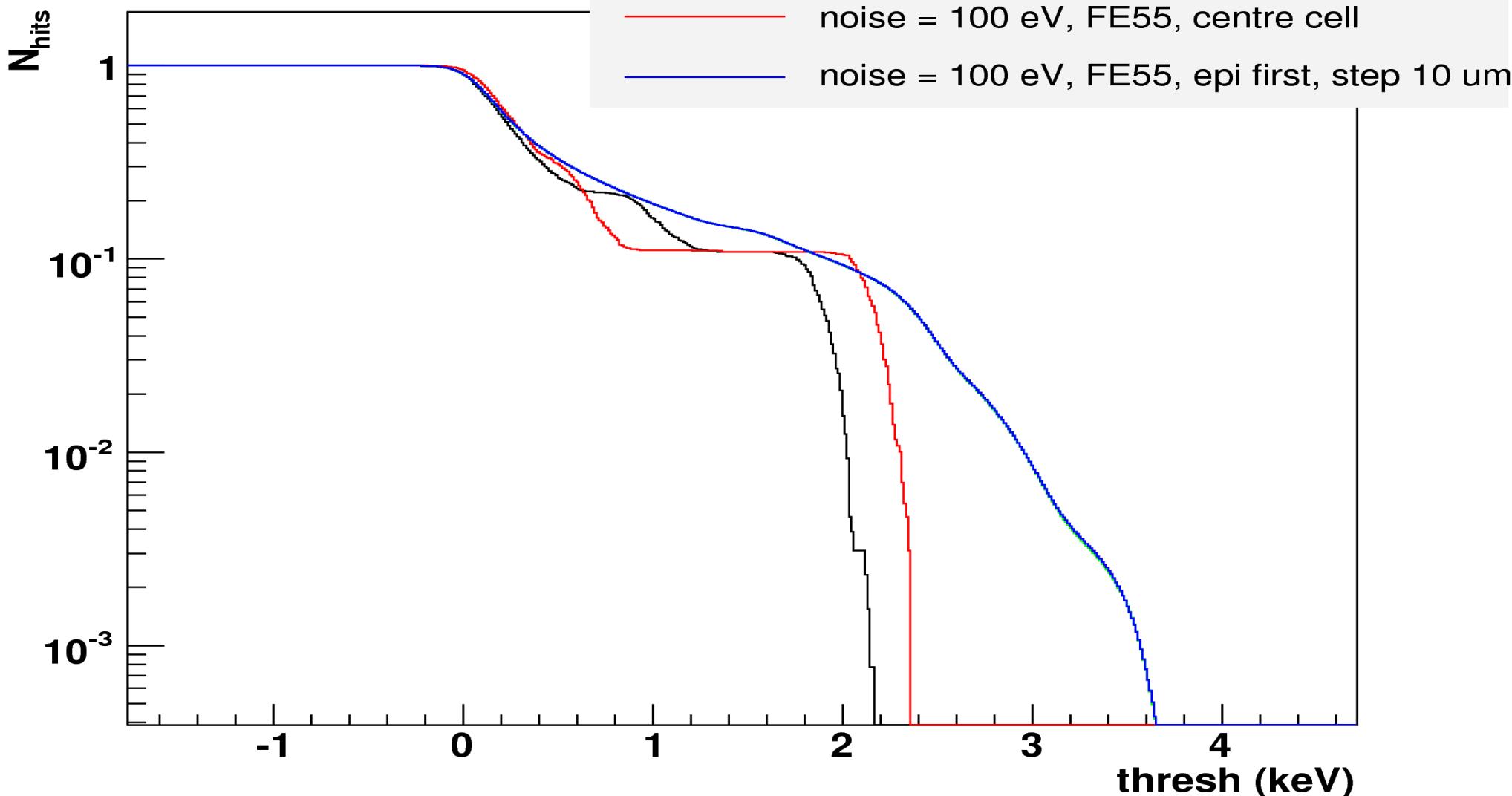
From F. Loparco, 9th Topical Seminar on Innovative Particle and Radiation Detectors May 23-26, 2004- Siena, Italy,
“A full Monte Carlo simulation code for silicon strip detectors”



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“A full Monte Carlo simulation code for silicon strip detectors”*

^{55}Fe , $\gamma = 7 \text{ keV}$

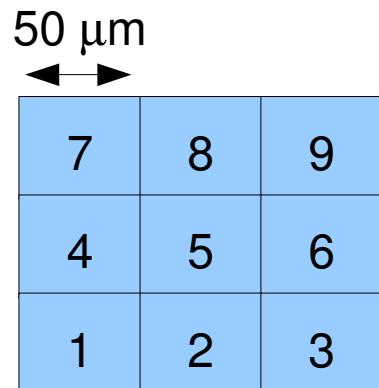
N_{hits} vs threshold



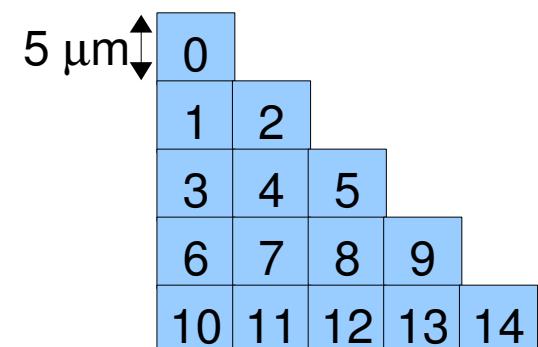
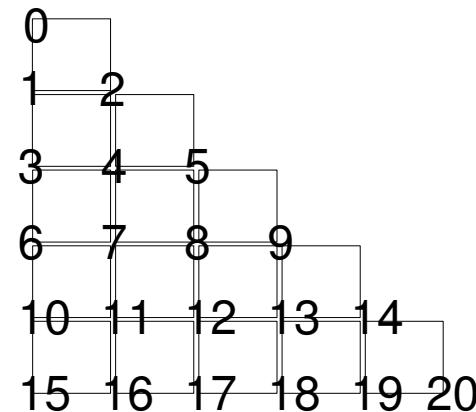
Charge spread : last results from
Giulio in terms of what will be
applied to Geant4 deposits

- N-well simple = first simulation of n-well with a simple model.
- Perfect p-well = assuming n-well is completely screened by p-well=inexistent. Rest of the pixel is GDS
- No DPW = GDS file with full n-well simulation, no DPW, array of 3*3 but only middle cell simulated.
- DPW = GDS with full simulation of everything, array of 3*3 but only middle cell simulated.

Cell indexing

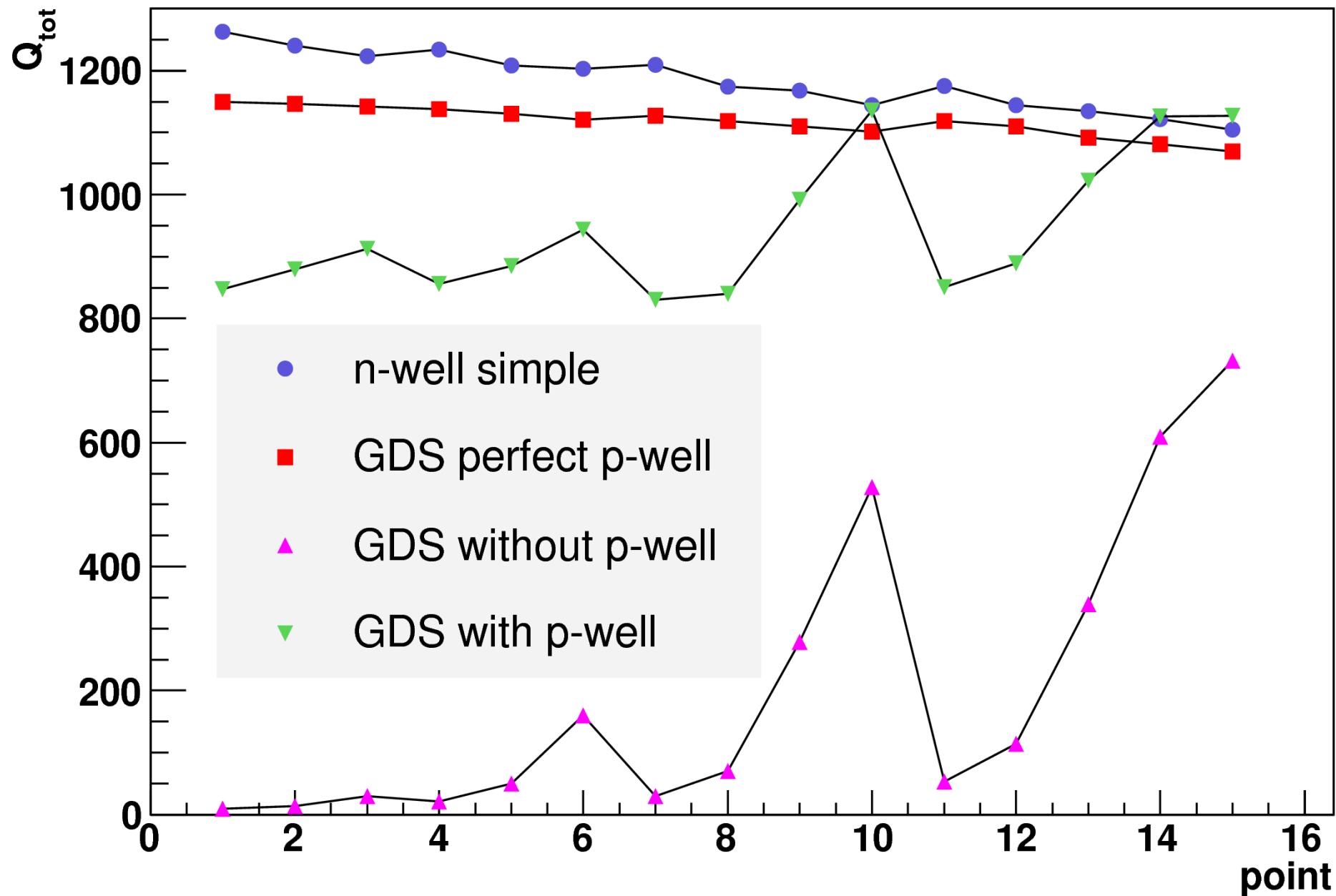


Point indexing

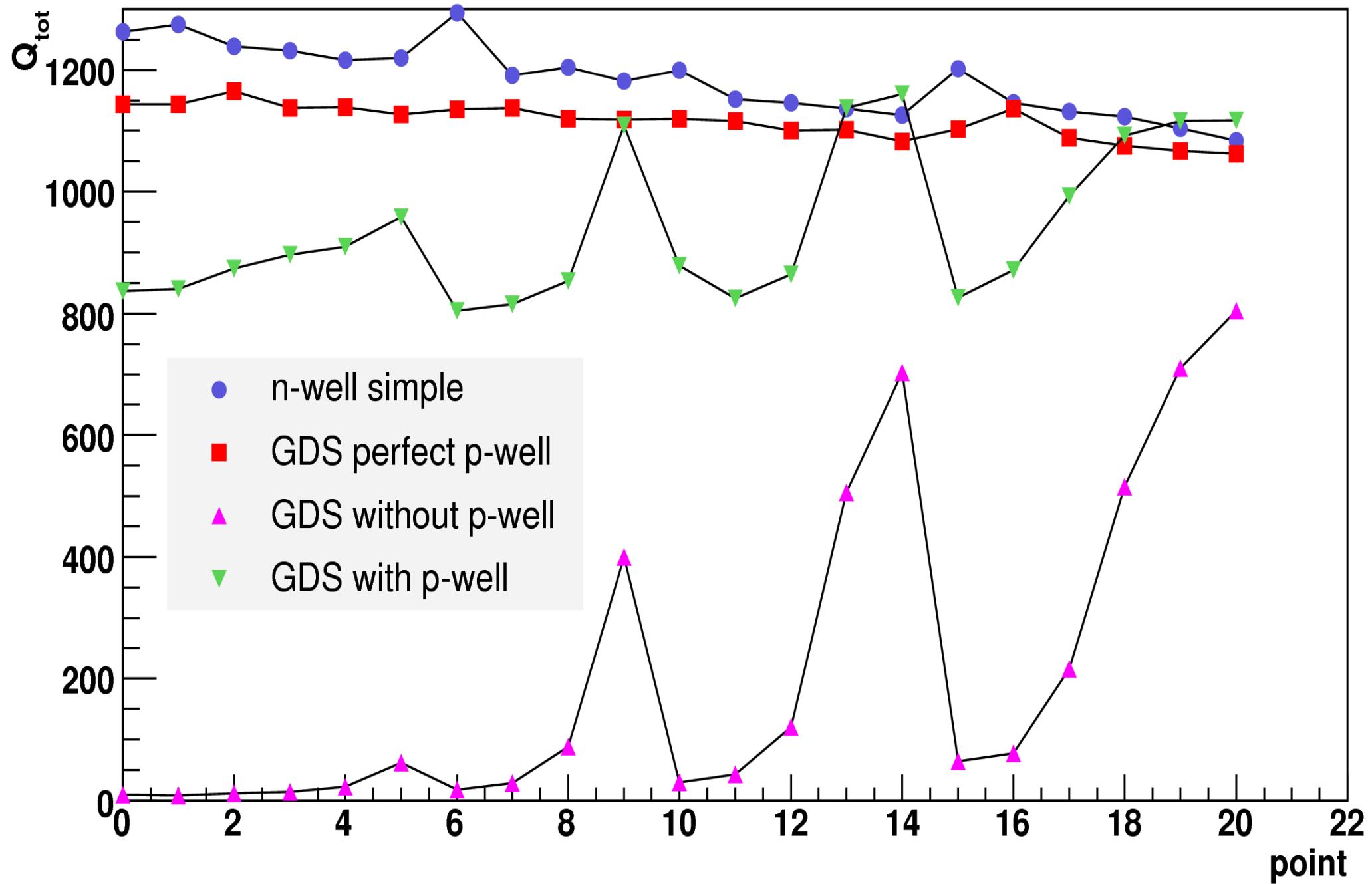


Just summing over the whole 3*3 cells the charge collected according
to the position of the input MIP.

Sum per point



Sum per point



Slide 5 – 6 – 7 – 8 : distribution of the sum over the 4 diodes, as a function of the cell index, for each of the 15 points.

Slide 9 – 10 – 11 – 12 : same, but as a function of the point index, for each of the 9 cells.

Slide 13 – 14 – 15 – 16 – 17 : with 21 points

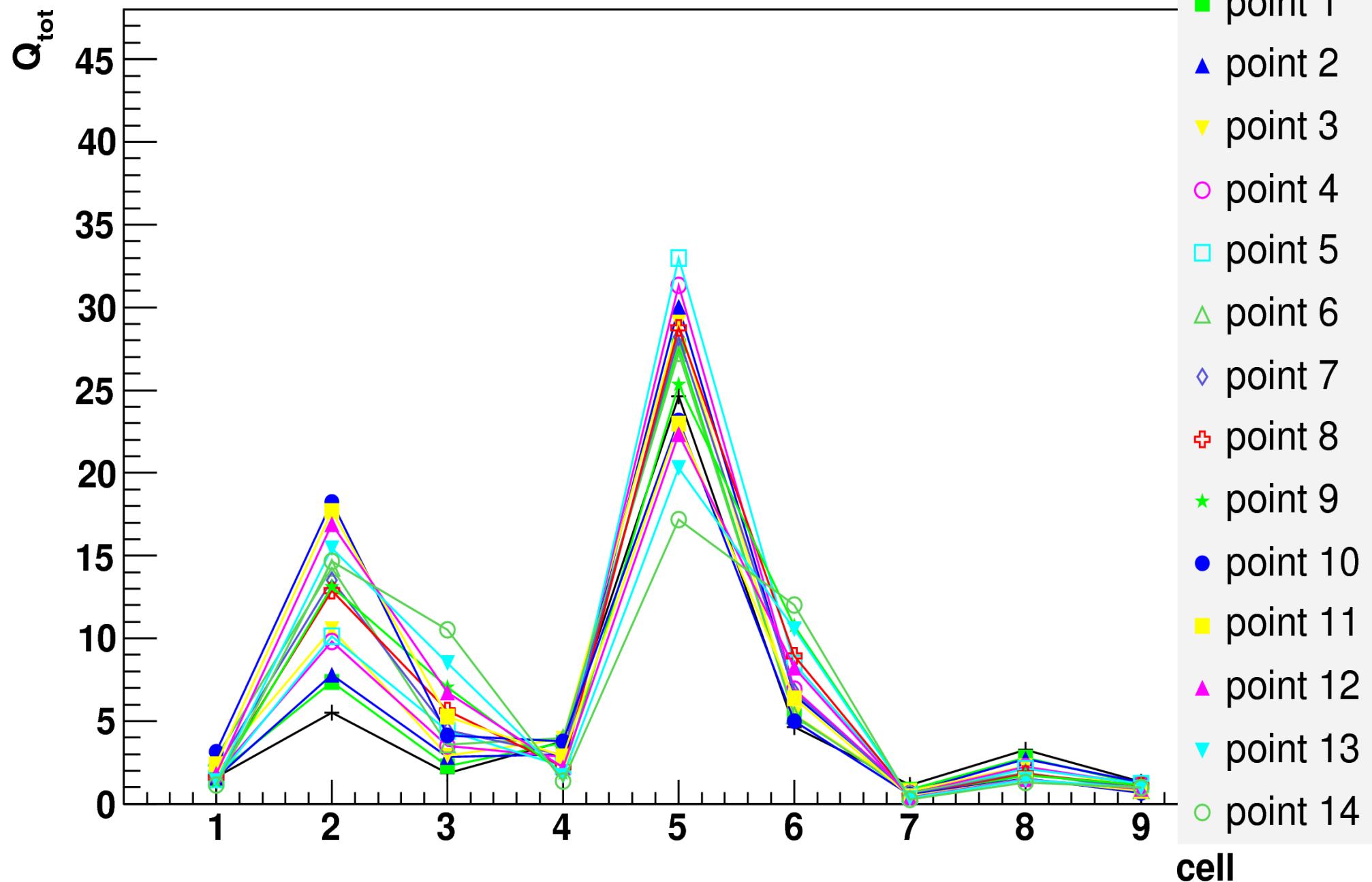
N.B.: the points are averaged compared to the 21 points given by Giulio to have the result in the center of a 5*5 cell...

So each “new point” = $(\text{sum_}(4 \text{ corners})/4)$

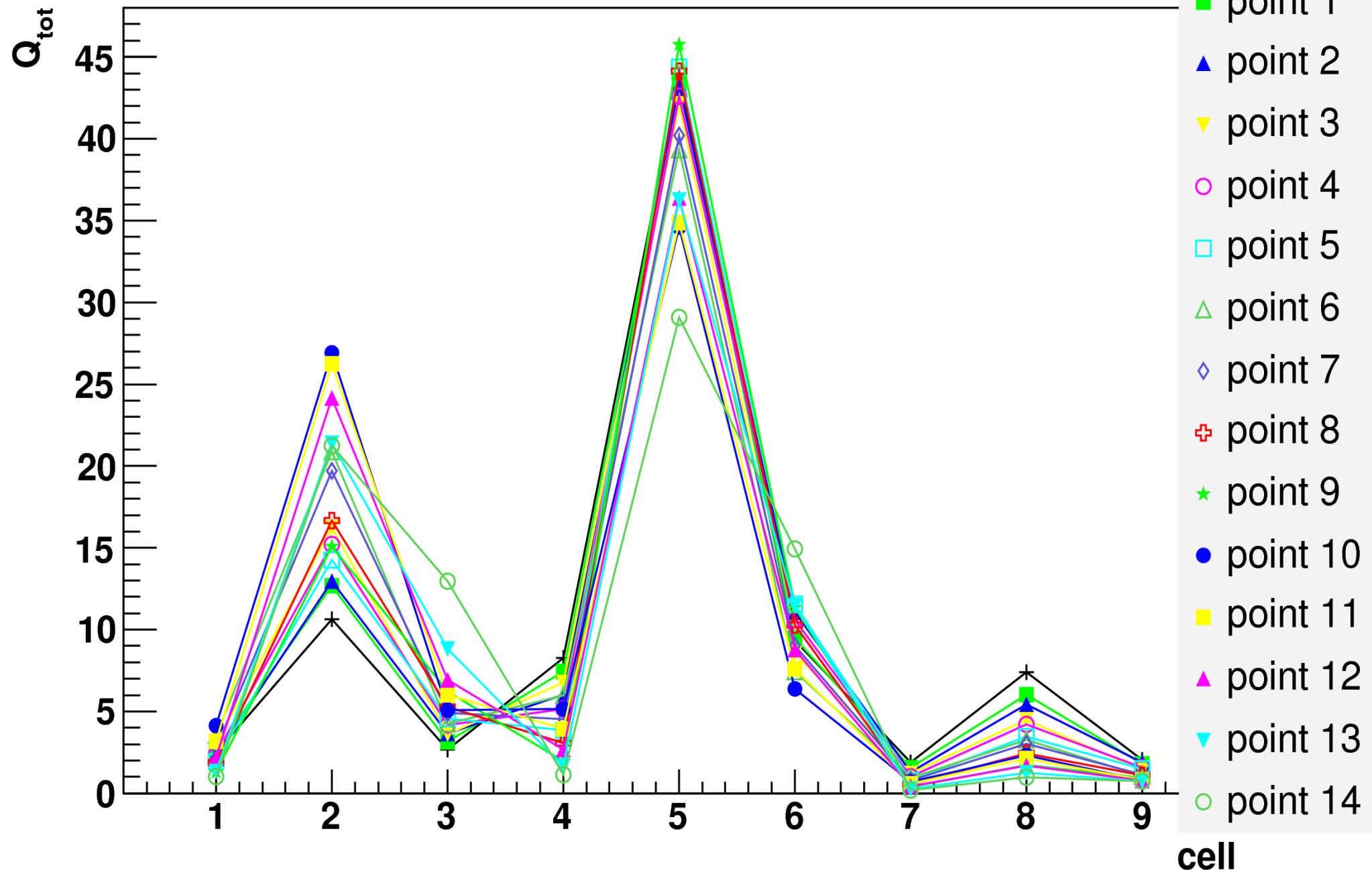
This implies the last point (#14) is biased towards the middle cell, and hence cell #5 collects more charge than the others.

However, cells #2 and 6 should be equivalent: they are not.

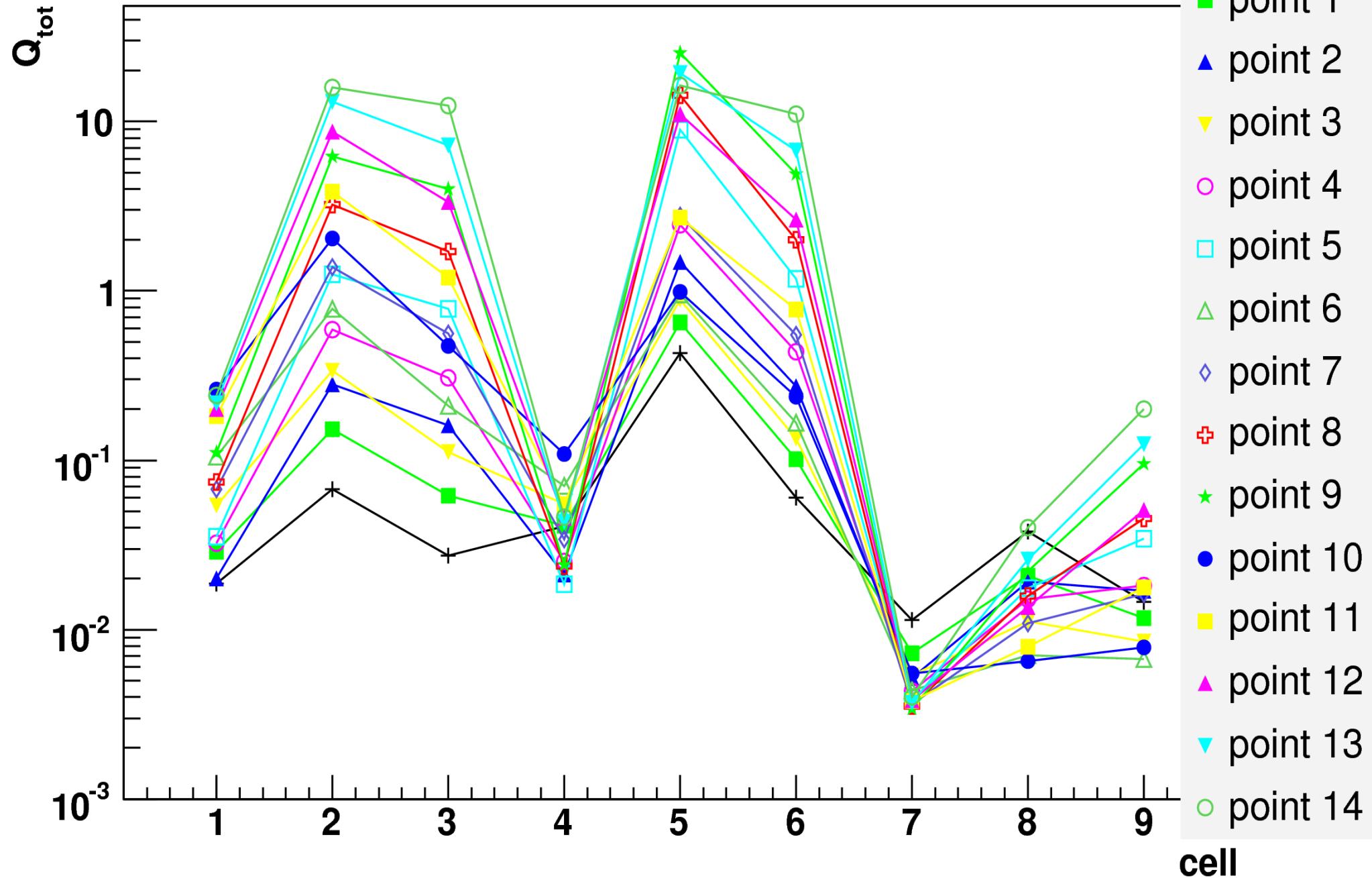
n-well simple



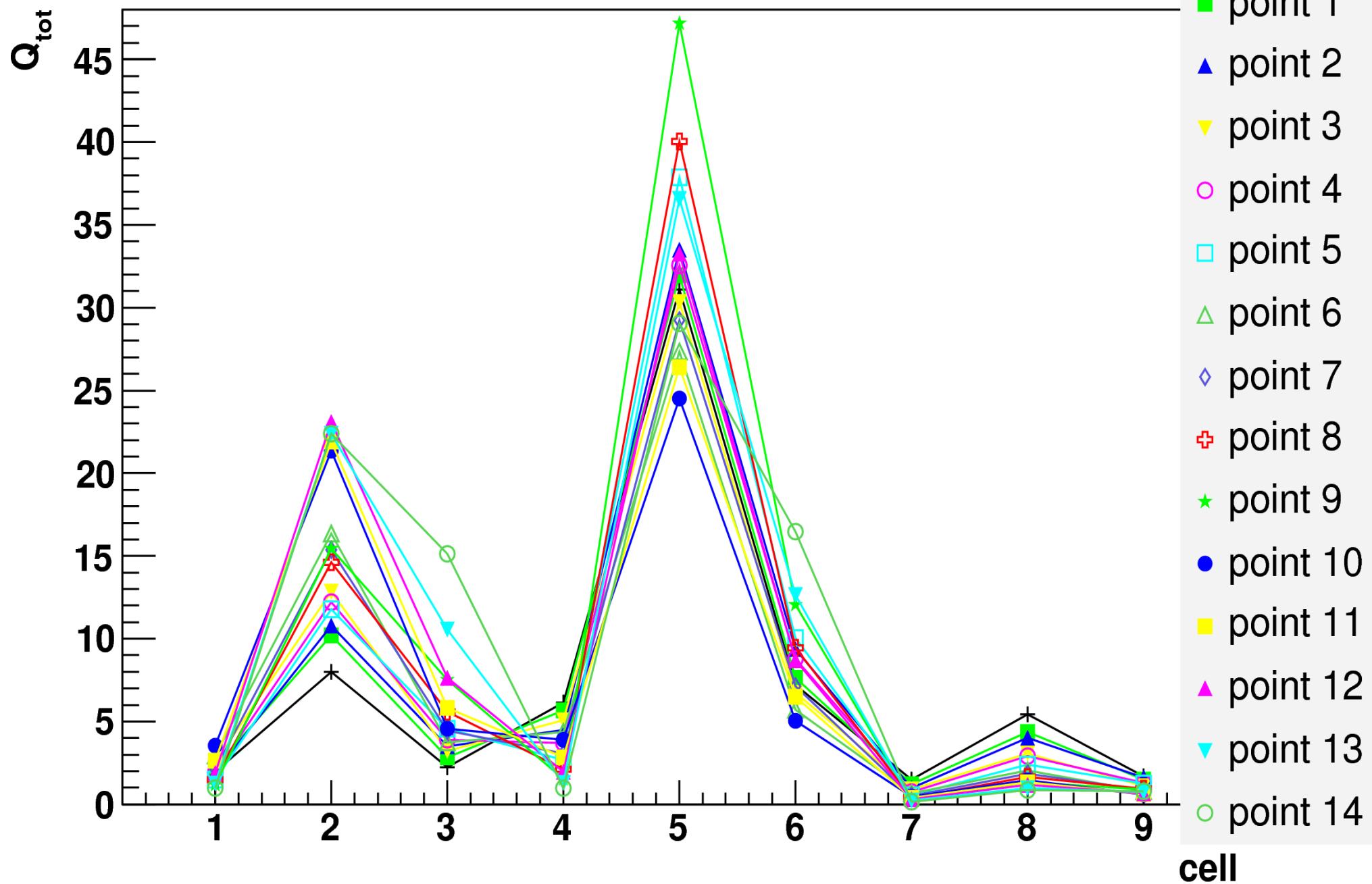
perfect p-well



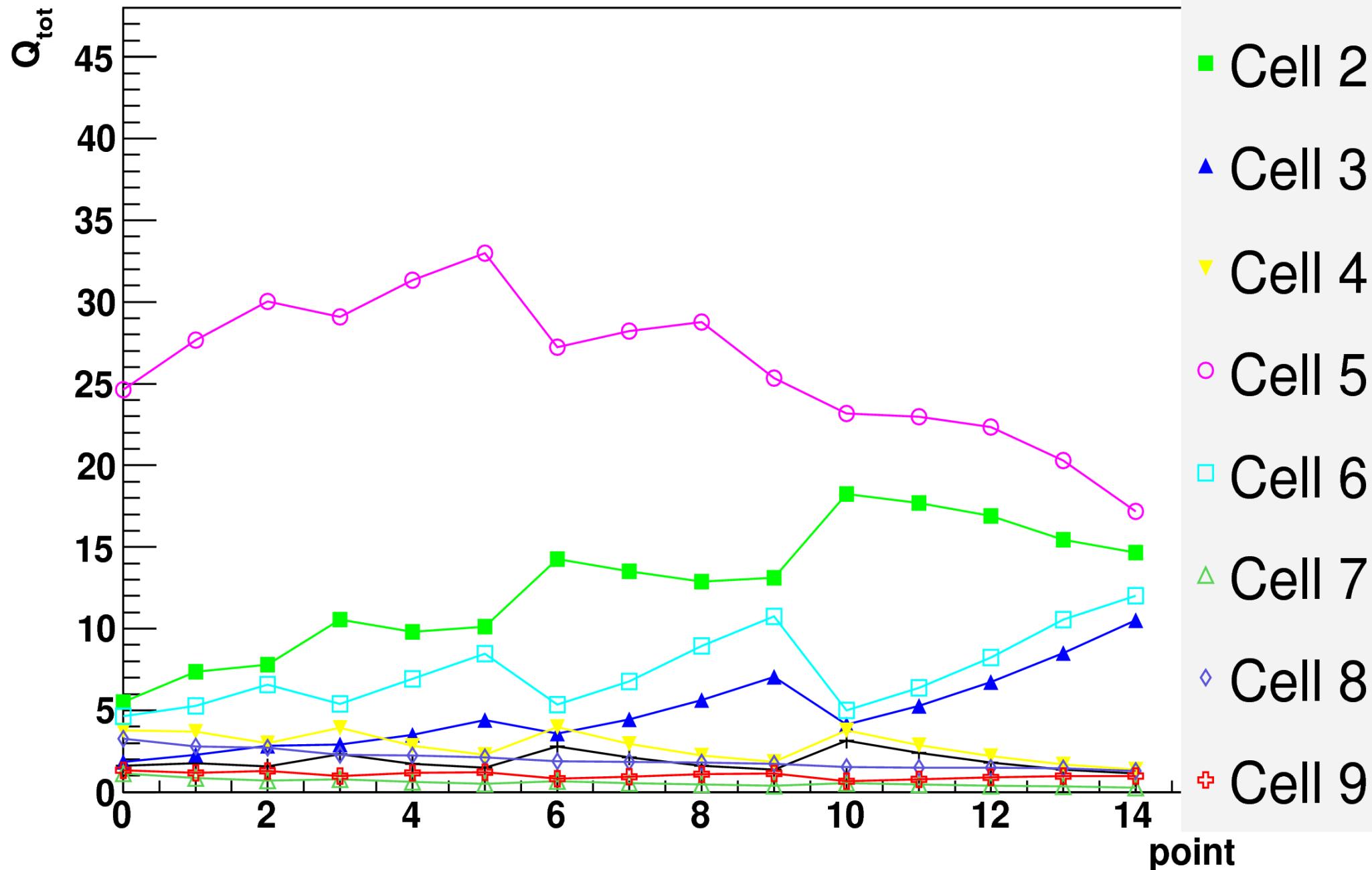
GDS no deep p-well



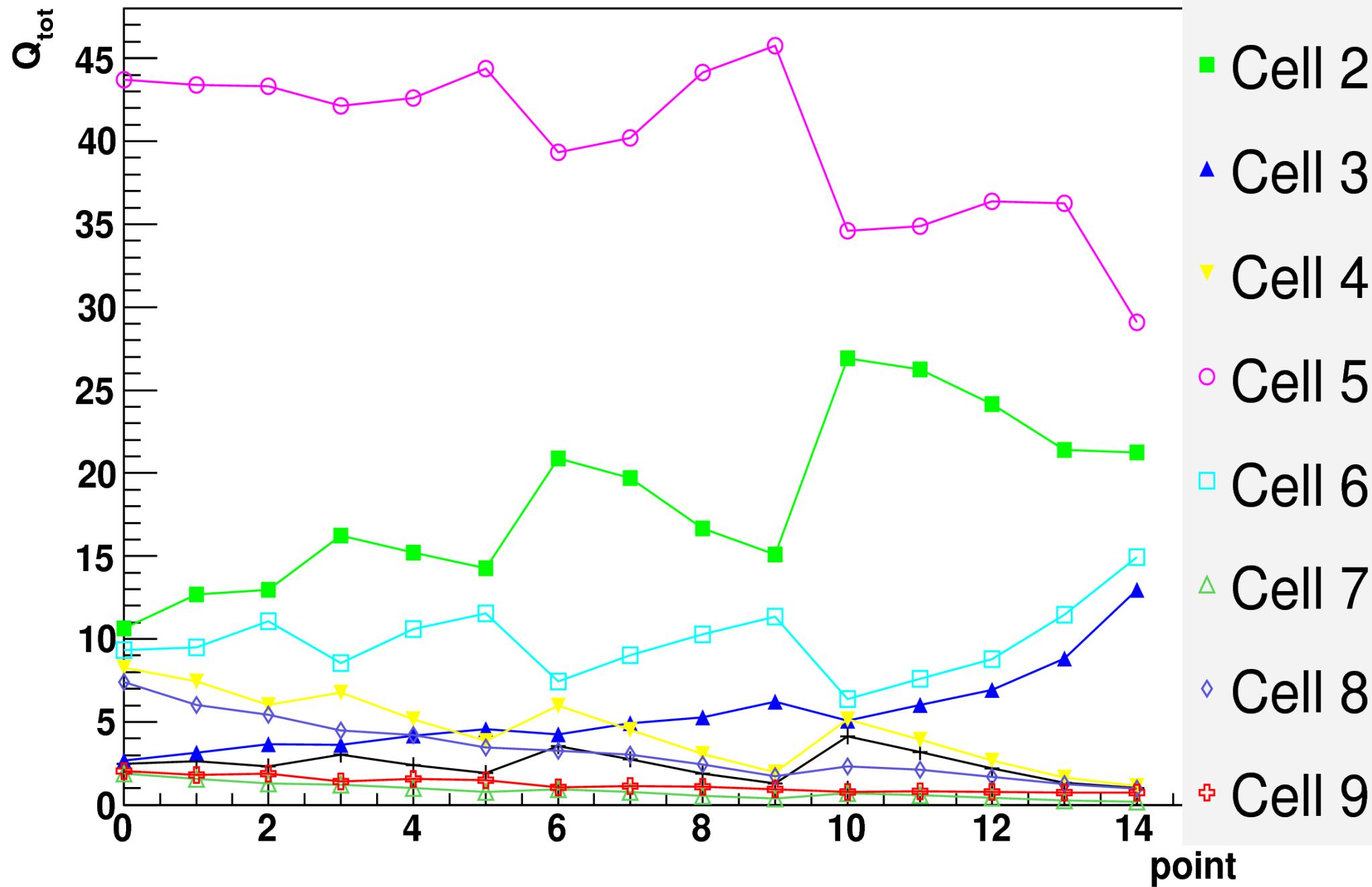
GDS deep p-well



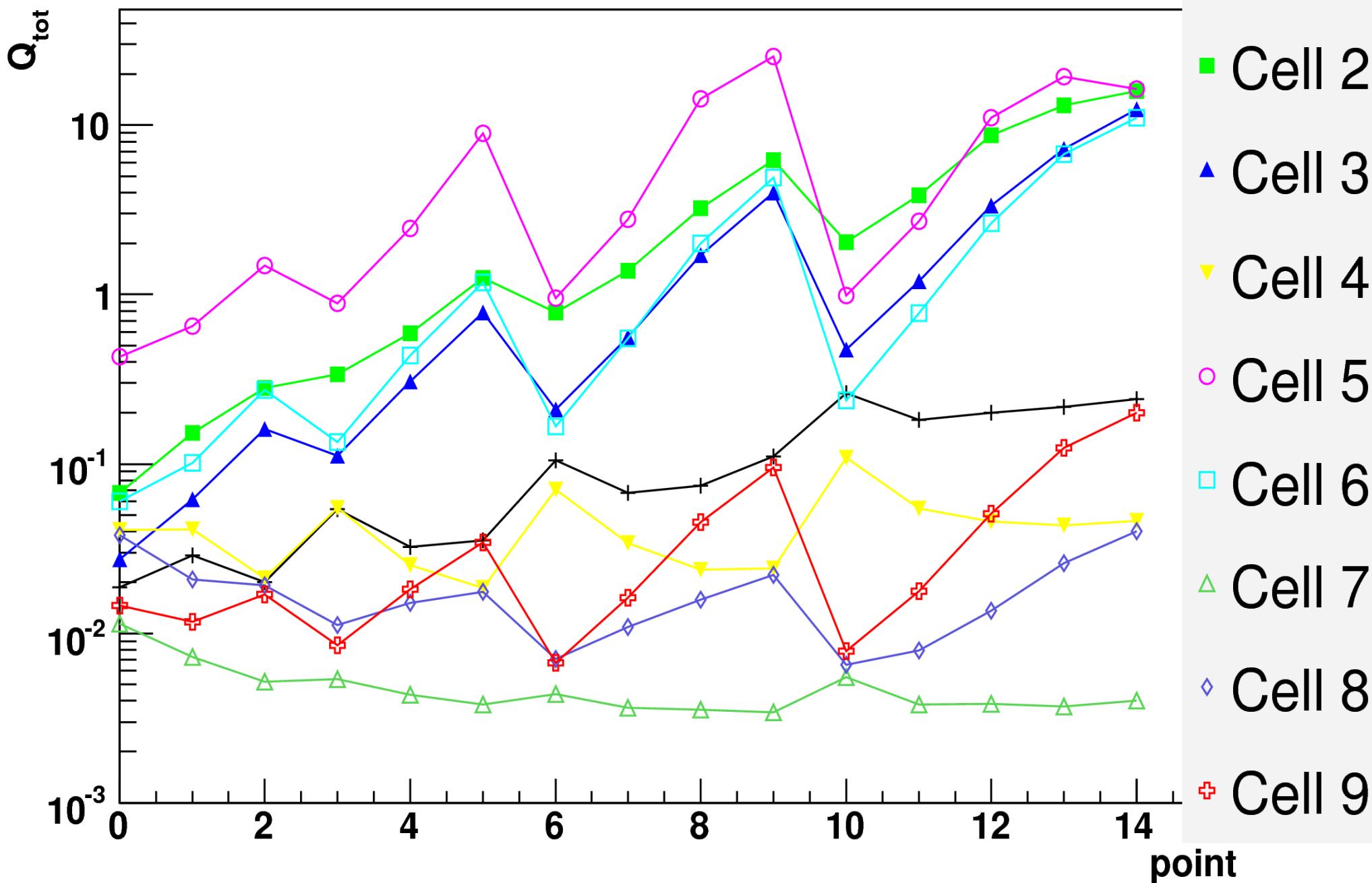
n-well simple



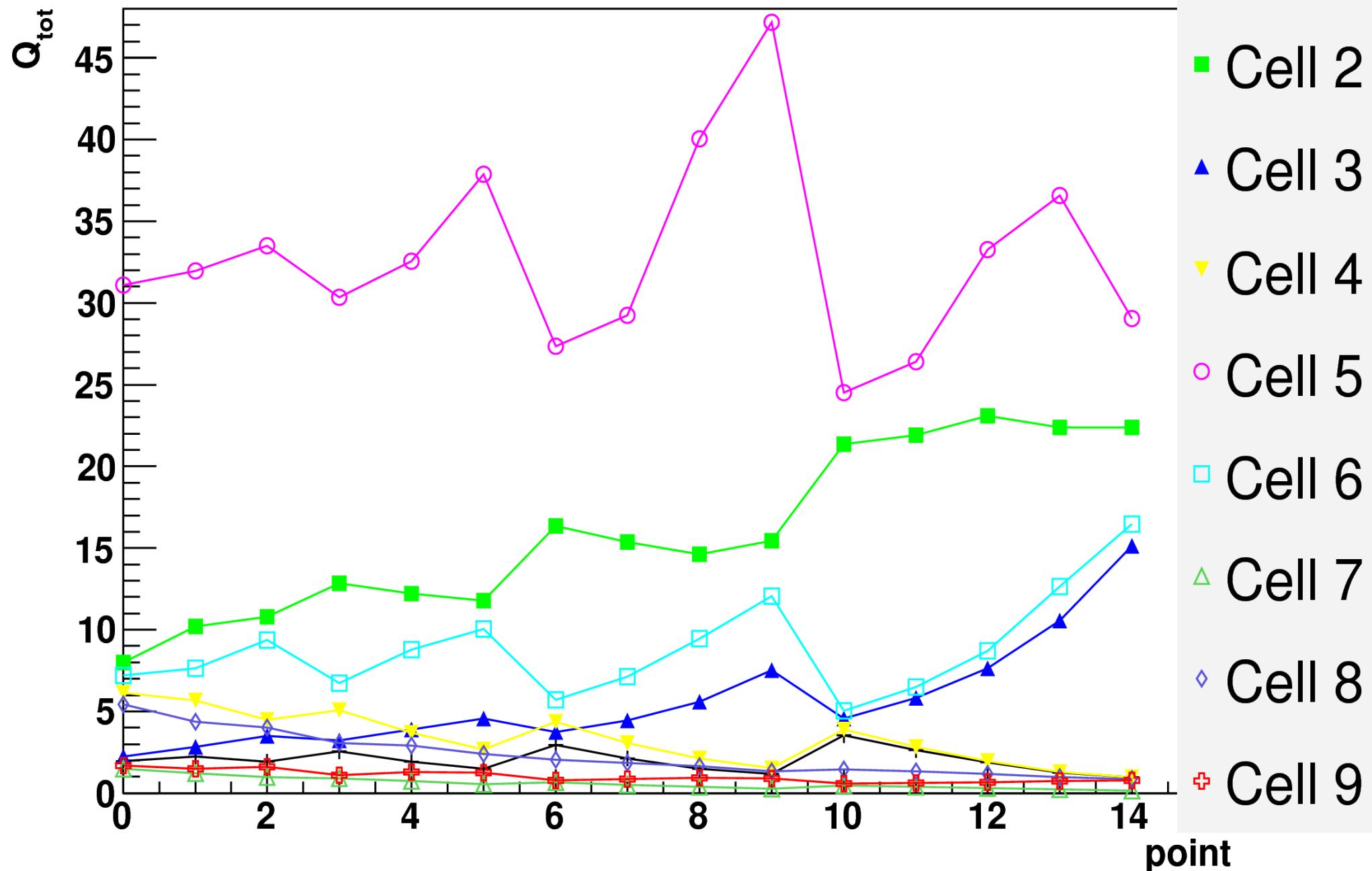
perfect p-well



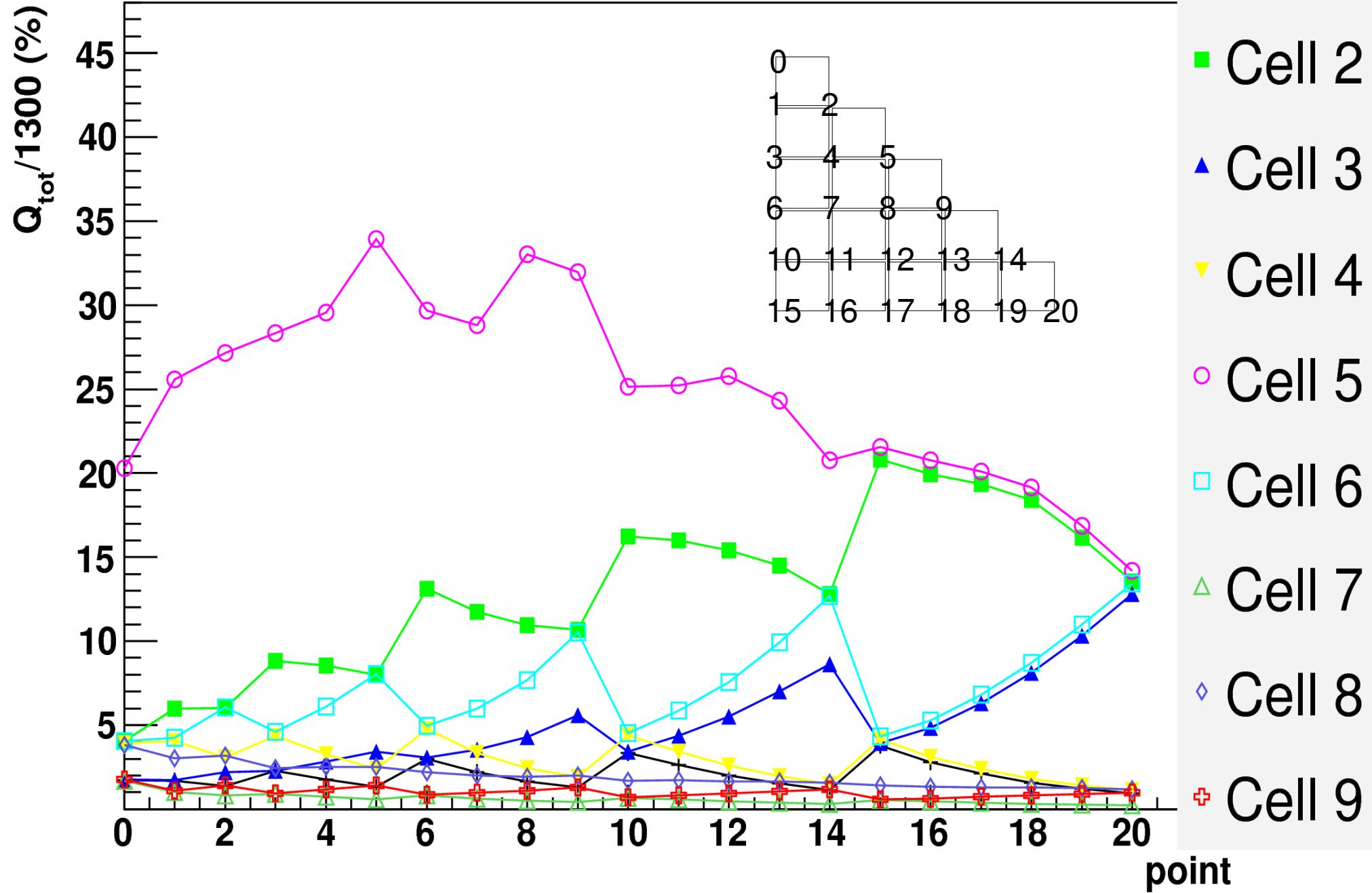
GDS no deep p-well



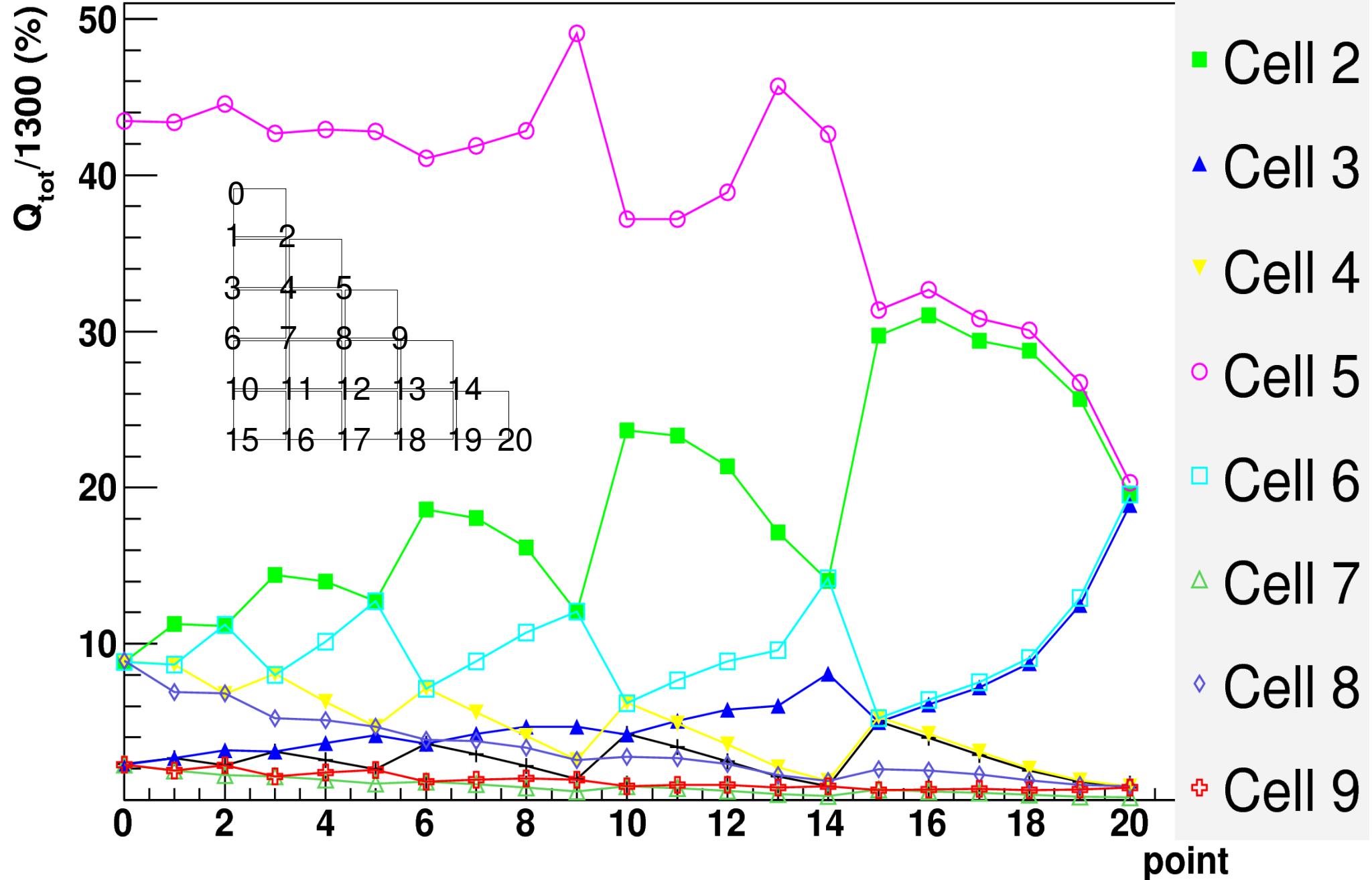
GDS deep p-well



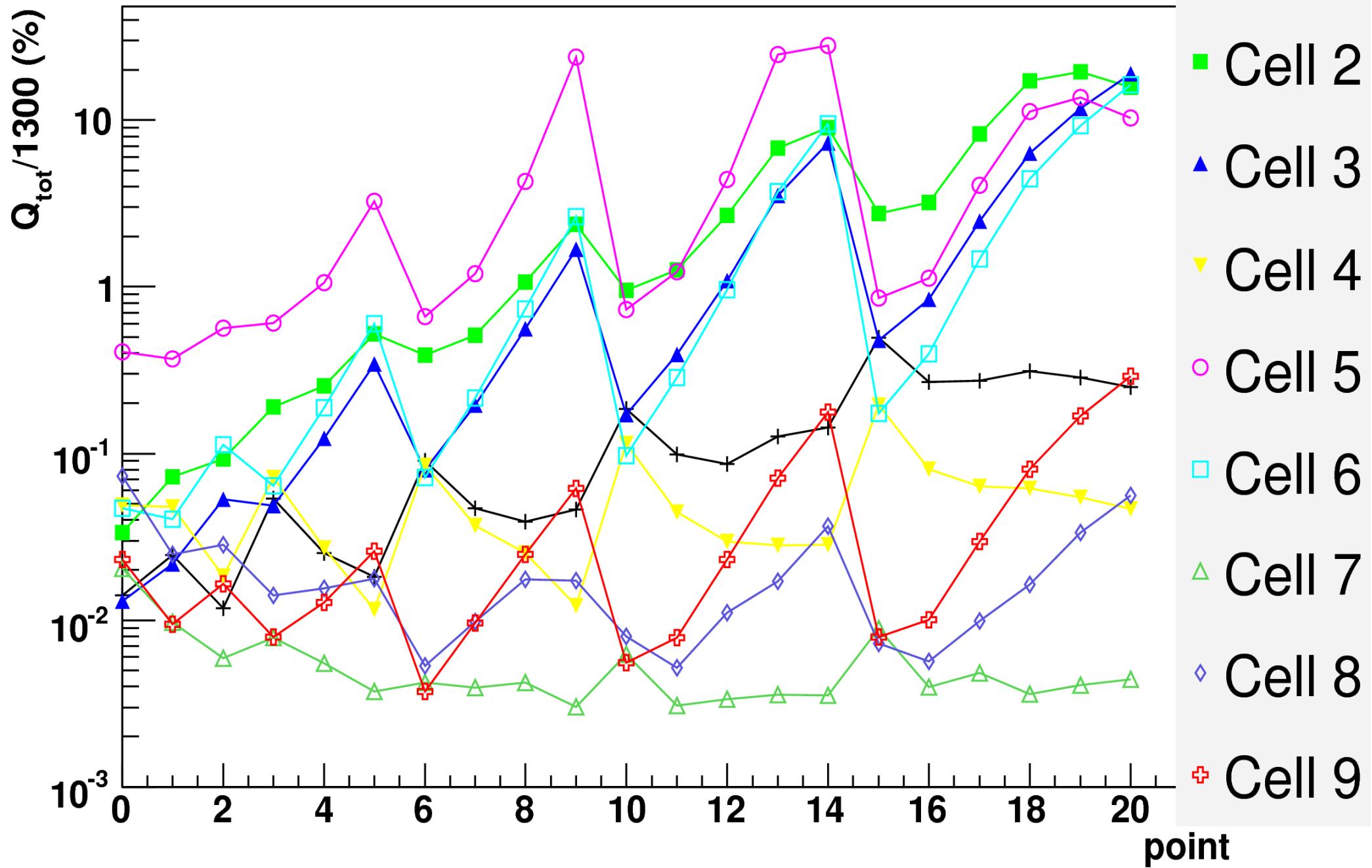
n-well simple



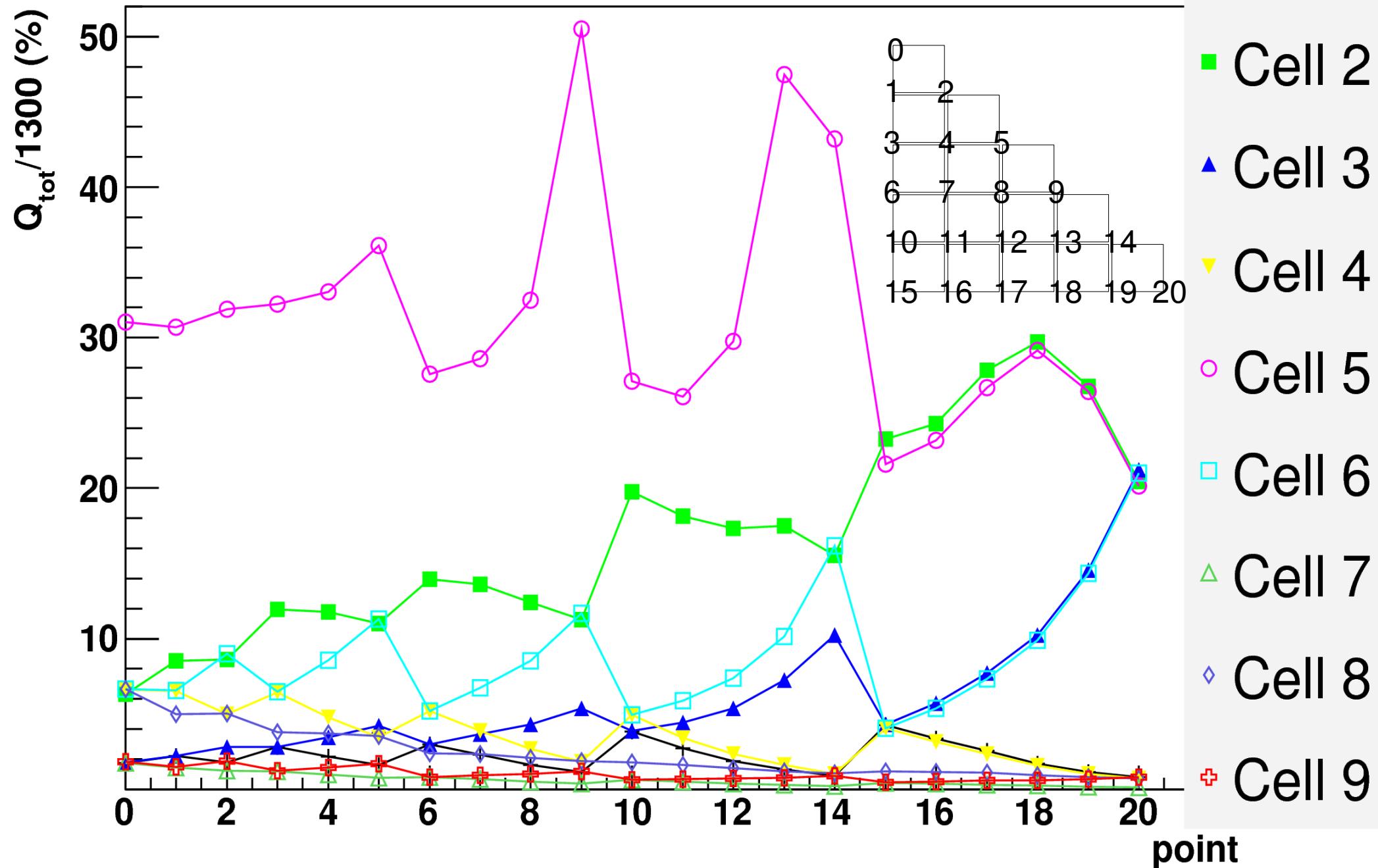
perfect p-well



GDS no deep p-well



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